Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/758,967	JEROME A HAPKA ET AL	
Examiner	Art Unit	_
Phi D. A	3637	

	SEAR	CHED	
Class	Subclass	Date	Examiner
52	208	6/11/06	PA
	204.55	1	
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	204.64		
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	204.72		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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(INCLUDING SEAR	NOTES CH STRATEG	Y)
	DATE	EXMR